

Description

The AO4612 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and

operation with gate voltages as low as 4.5V. This

device is suitable for use as a

Battery protection or in other Switching application.

General Features

V_{DS} = 60V I_D =8.5A

 $R_{DS(ON)} < 48m\Omega @ V_{GS}=10V$

V_{DS} = -60V I_D =-7.7A

 $R_{DS(ON)} < 85 \text{ m}\Omega @ V_{GS}=-10V$

Application

Wireless charging

Boost driver

Brushless motor

Package Marking and Ordering Information

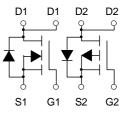
| Product ID | Pack | Marking Qty(PC | | |
|------------|-------|----------------|------|--|
| AO4612 | SOP-8 | 4612XXX | 3000 | |

Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

| | Barran | Rati | Units | |
|-------------------------|--|------------|---------------------|--------------|
| Symbol | Parameter | N-Channel | N-Channel P-Channel | |
| VDS | DS Drain-Source Voltage | | -60 | V |
| VGS | Gate-Source Voltage | ±20 | ±20 | V |
| I₀@T _A =25℃ | Continuous Drain Current, V _{GS} @ 10V ¹ | 8.5 | -7.7 | А |
| I₀@T _A =70°℃ | Continuous Drain Current, V _{GS} @ 10V ¹ | 4.0 | -3 | А |
| IDM | Pulsed Drain Current ² | 20 | -14 | А |
| EAS | Single Pulse Avalanche Energy ³ | 22 | 28.8 | mJ |
| IAS | Avalanche Current | 21 | -24 | А |
| P D@T A=25℃ | Total Power Dissipation ⁴ | 2 | 2 | W |
| TSTG | Storage Temperature Range | -55 to 150 | -55 to 150 | °C |
| TJ | Operating Junction Temperature Range | -55 to 150 | -55 to 150 | °C |
| R₀JA | Thermal Resistance Junction-Ambient ¹ | 85 | | °C /W |
| R₀JC | Thermal Resistance Junction-Case ¹ | 62.5 | | °C/W |



SOP-8



N-Channel and P-Channel



| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit | |
|------------------------------------|--|--|------|-------|------|-------|--|
| BVDSS | Drain-Source Breakdown Voltage | V _{GS} =0V , I _D =250uA | 60 | 65 | | V | |
| ∆BVDSS/∆TJ | BV _{DSS} Temperature Coefficient | Reference to 25°C , I _D =1mA | | 0.063 | | V/°C | |
| | Static Drain-Source On-Resistance ² | V _{GS} =10V , I _D =5A | | 35 | 48 | mΩ | |
| RDS(ON) | | V _{GS} =4.5V , I _D =4A | | 41 | 65 | | |
| VGS(th) | Gate Threshold Voltage | V _{GS} =V _{DS} , I _D =250uA | 1.2 | 1.75 | 2.5 | V | |
| $\bigtriangleup V_{\text{GS(th)}}$ | $V_{GS(th)}$ Temperature Coefficient | VGS-VDS, ID -2500A | | -5.24 | | mV/°C | |
| IDSS | Drain-Source Leakage Current | V _{DS} =48V , V _{GS} =0V , T _J =25°C | | | 1 | | |
| 1055 | | V _{DS} =48V , V _{GS} =0V , T _J =55°C | | | 5 | uA | |
| IGSS | Gate-Source Leakage Current | V _{GS} =±20V , V _{DS} =0V | | | ±100 | nA | |
| gfs | Forward Transconductance | V _{DS} =5V , I _D =4A | | 28 | | S | |
| Qg | Total Gate Charge (4.5V) | | | 19 | | nC | |
| Qgs | Gate-Source Charge | V _{DS} =48V , V _{GS} =4.5V , I _D =4A | | 2.6 | | | |
| Qgd | Gate-Drain Charge | | | 4.1 | | | |
| Td(on) | Turn-On Delay Time | | | 3 | | | |
| Tr | Rise Time Turn-Off Delay Time | V _{DD} =30V , V _{GS} =10V , R _G =3.3Ω, I _D =4A | | 34 | | ns | |
| Td(off) | | | | 23 | | | |
| T _f | Fall Time | | | 6.0 | | | |
| Ciss | Input Capacitance | | | 1027 | | | |
| Coss | Output Capacitance | V _{DS} =15V , V _{GS} =0V , f=1MHz | | 65 | | pF | |
| Crss | Reverse Transfer Capacitance | | | 45 | | | |
| IS | Continuous Source Current ^{1,5} | $V_G=V_D=0V$, Force Current | | | 2.5 | Α | |
| VSD | VSD Diode Forward Voltage ² V _{GS} =0V , I _S =1A , T _J =25°C | | | | 1.2 | V | |

N-Channel Electrical Characteristics (TJ =25 °C, unless otherwise noted)

Note :

1. The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.

 $2\,{\scriptstyle \sim}\,$ The data tested by pulsed , pulse width $\leq 300 us$, duty cycle $\leq 2\%$

3. The power dissipation is limited by 150°C junction temperature

4. The data is theoretically the same as I D and I DM, in real applications, should be limited by total power dissipation



| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit | |
|----------------|---|--|------|-------|------|-------|--|
| BVDSS | Drain-Source Breakdown Voltage | ge V _{GS} =0V , I _D =-250uA | | -65 | | V | |
| ∆BVDSS/∆TJ | $DSS/\Delta TJ$ BV _{DSS} Temperature Coefficient Reference to 25°C , I _D =-1mA | | | -0.03 | | V/°C | |
| RDS(ON) | Static Drain-Source On-Resistance ² | V _{GS} =-10V , I _D =-3A | | 72 | 85 | mΩ | |
| RD3(ON) | | V _{GS} =-4.5V , I _D =-2A | | 100 | 105 | 11122 | |
| VGS(th) | Gate Threshold Voltage | V_{GS} = V_{DS} , I_D =-250uA | -1.2 | 1.75 | -2.5 | V | |
| | Drain-Source Leakage Current | V _{DS} =-48V , V _{GS} =0V , T _J =25°C | | | 1 | uA | |
| IDSS | | V _{DS} =-48V , V _{GS} =0V , T _J =55°C | | | 5 | | |
| IGSS | Gate-Source Leakage Current | V_{GS} =±20V , V_{DS} =0V | | | ±100 | nA | |
| gfs | fs Forward Transconductance V _{DS} =-5V , I _D =-3A | | | 8.5 | | S | |
| Qg | Total Gate Charge (-4.5V) | | | 12.1 | | | |
| Qgs | Gate-Source Charge | V _{DS} =-48V , V _{GS} =-4.5V , I _D =-3A | | 2.2 | | nC | |
| Qgd | Gate-Drain Charge | | | 6.3 | | | |
| Td(on) | Turn-On Delay Time | | | 9.2 | | | |
| Tr | Rise Time | V _{DD} =-15V , V _{GS} =-10V , | | 20.1 | | | |
| Td(off) | Turn-Off Delay Time | R _G =3.3□, I _D =-1A | | 46.7 | | ns | |
| T _f | Fall Time | | | 9.4 | | | |
| Ciss | Input Capacitance | | | 1137 | | | |
| Coss | Output Capacitance | V _{DS} =-15V , V _{GS} =0V , f=1MHz | | 76 | | pF | |
| Crss | Reverse Transfer Capacitance | | | 50 | | | |
| IS | Continuous Source Current ^{1,5} | $V_G=V_D=0V$, Force Current | | | -2.5 | Α | |
| VSD | VSD Diode Forward Voltage ² V _{GS} =0V , I _S =-1A , T _J =25°C | | | | -1.2 | V | |

P-Channel Electrical Characteristics (TJ =25 °C, unless otherwise noted)

Note :

1、The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.

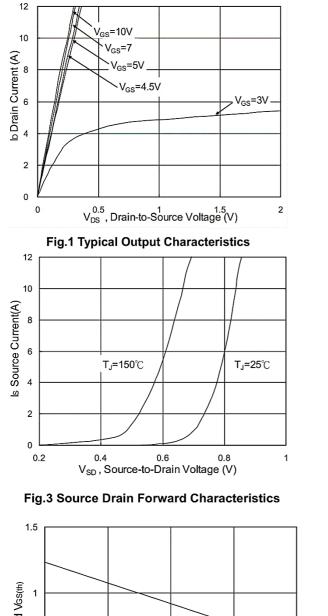
2、 The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%

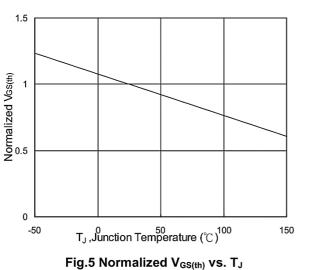
3. The power dissipation is limited by 150°C junction temperature

4、The data is theoretically the same as I D and I DM , in real applications , should be limited by total power dissipation.



N-Channel Typical Characteristics





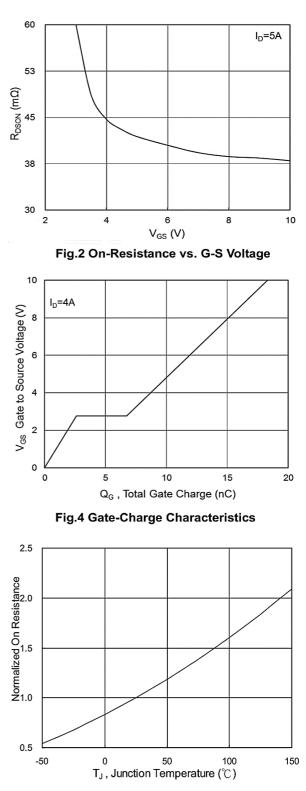
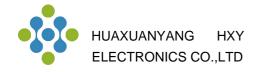


Fig.6 Normalized R_{DSON} vs. T_J



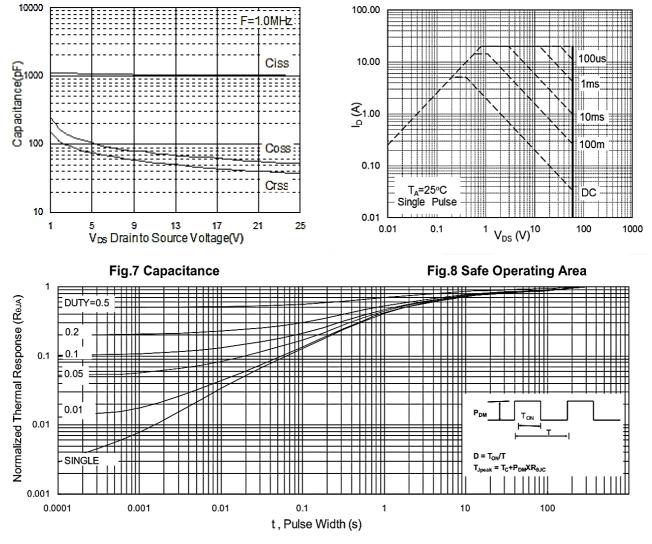


Fig.9 Normalized Maximum Transient Thermal Impedance

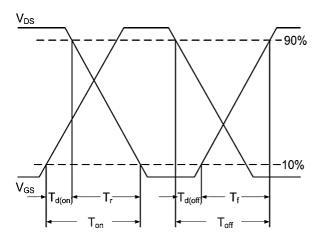
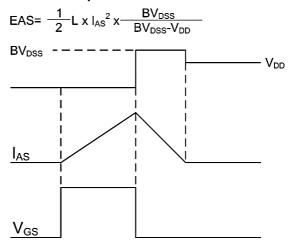
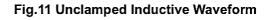


Fig.10 Switching Time Waveform







P-Channel Typical Characteristics

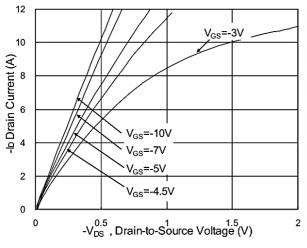


Fig.1 Typical Output Characteristics

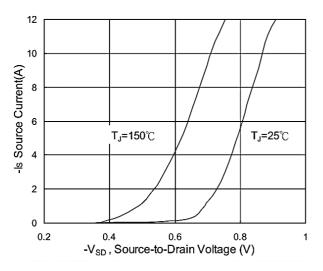
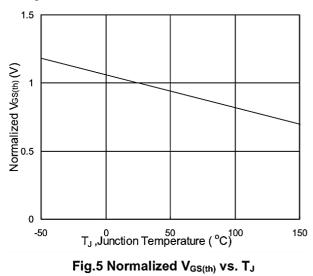


Fig.3 Source Drain Forward Characteristics



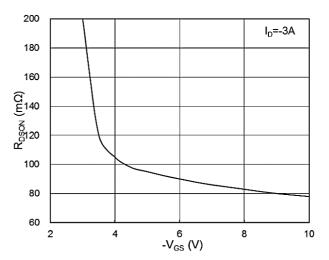


Fig.2 On-Resistance vs. G-S Voltage

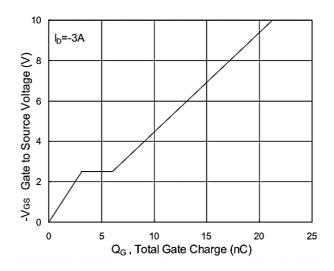


Fig.4 Gate-Charge Characteristics

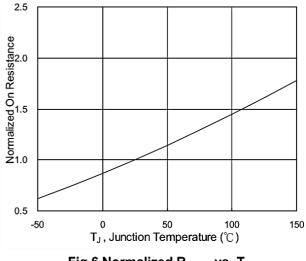


Fig.6 Normalized R_{DSON} vs. T_J



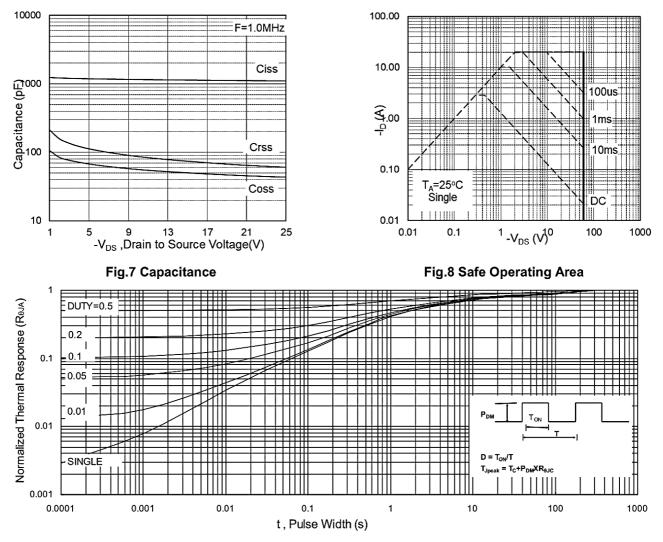


Fig.9 Normalized Maximum Transient Thermal Impedance

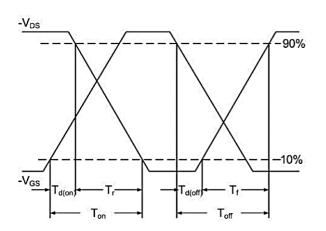
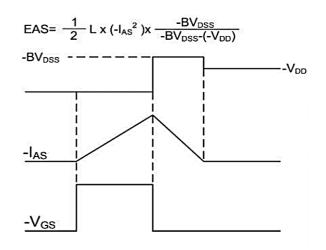
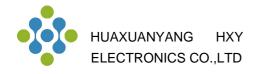


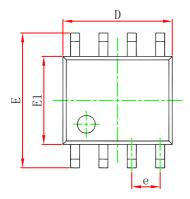
Fig.10 Switching Time Waveform

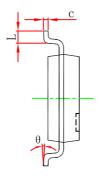


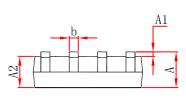




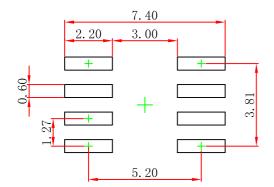
SOP-8 Package Outline Dimensions







| Symbol | Dimensions In Millimeters | | Dimensions In Inches | | |
|--------|---------------------------|-------|----------------------|-------|--|
| Symbol | Min | Max | Min | Max | |
| Α | 1.350 | 1.750 | 0.053 | 0.069 | |
| A1 | 0.100 | 0.250 | 0.004 | 0.010 | |
| A2 | 1.350 | 1.550 | 0.053 | 0.061 | |
| b | 0.330 | 0.510 | 0.013 | 0.020 | |
| с | 0.170 | 0.250 | 0.007 | 0.010 | |
| D | 4.800 | 5.000 | 0.189 | 0.197 | |
| e | 1.270 (BSC) | | 0.050 (BSC) | | |
| E | 5.800 | 6.200 | 0.228 | 0.244 | |
| E1 | 3.800 | 4.000 | 0.150 | 0.157 | |
| L | 0.400 | 1.270 | 0.016 | 0.050 | |
| θ | 0 ° | 8° | 0 ° | 8° | |



Note: 1.Controlling dimension: in millimeters.

2.General tolerance:± 0.05mm.
 3.The pad layout is for reference purposes only.



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